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| Notice of References Cited | Application/Control No. 10/823,537 | Applicant(s)/Patent Under Reexamination HSU, HSIEN-YUEH | |
| | Examiner Vincent T. Tran | Art Unit 2115 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------------------|----------------|
| * | A | US-6,813,674 | 11-2004 | Velasco et al. | 710/311 |
| * | B | US-5,987,614 | 11-1999 | Mitchell et al. | 713/300 |
| * | C | US-5,189,314 | 02-1993 | Georgiou et al. | 327/114 |
| * | D | US-5,715,467 | 02-1998 | Jirgal, James J. | 713/300 |
| * | E | US-5,546,591 | 08-1996 | Wurzburg et al. | 713/322 |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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